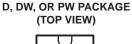
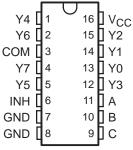
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- Controlled Baseline
  - One Assembly/Test Site, One Fabrication Site
- Extended Temperature Performance of -40°C to 105°C
- Enhanced Diminishing Manufacturing Sources (DMS) Support
- Enhanced Product-Change Notification
- Qualification Pedigree<sup>†</sup>
- 2-V to 5.5-V V<sub>CC</sub> Operation
- Supports Mixed-Mode Voltage Operation on All Ports
- High On-Off Output-Voltage Ratio
- Low Crosstalk Between Switches
- † Component qualification in accordance with JEDEC and industry standards to ensure reliable operation over an extended temperature range. This includes, but is not limited to, Highly Accelerated Stress Test (HAST) or biased 85/85, temperature cycle, autoclave or unbiased HAST, electromigration, bond intermetallic life, and mold compound life. Such qualification testing should not be viewed as justifying use of this component beyond specified performance and environmental limits.

- Individual Switch Controls
- Extremely Low Input Current
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Protection Exceeds JESD 22
  - 2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)
  - 1000-V Charged-Device Model (C101)





#### description/ordering information

This 8-channel CMOS analog multiplexer/demultiplexer is designed for 2-V to 5.5-V V<sub>CC</sub> operation.

The SN74LV4051A handles both analog and digital signals. Each channel permits signals with amplitudes up to 5.5 V (peak) to be transmitted in either direction.

Applications include signal gating, chopping, modulation or demodulation (modem), and signal multiplexing for analog-to-digital and digital-to-analog conversion systems.

#### ORDERING INFORMATION

TA	PACK	AGE‡	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	SOIC - D	Tape and reel	SN74LV4051ATDREP	LV4051ATEP
-40°C to 105°C	SOIC - DW	Tape and reel	SN74LV4051ATDWREP§	LV4051ATEP
	TSSOP - PW	Tape and reel	SN74LV4051ATPWREP	L4051EP

<sup>‡</sup>Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

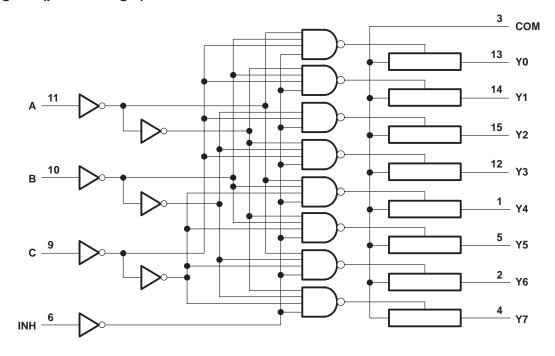


<sup>§</sup> Product Preview.

#### **FUNCTION TABLE**

	INP	UTS		ON
INH	С	В	Α	CHANNEL
L	L	L	L	Y0
L	L	L	Н	Y1
L	L	Н	L	Y2
L	L	Н	Н	Y3
L	Н	L	L	Y4
L	Н	L	Н	Y5
L	Н	Н	L	Y6
L	Н	Н	Н	Y7
Н	Χ	Χ	Χ	None

## logic diagram (positive logic)



### SN74LV4051A-EP 8-CHANNEL ANALOG MULTIPLEXER/DEMULTIPLEXER

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#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

oply voltage range, V <sub>CC</sub>	0.5 V to 7.0 V
ut voltage range, V <sub>I</sub> (see Note 1)	0.5 V to 7.0 V
itch I/O voltage range, V <sub>IO</sub> (see Notes 1 and 2)	$-0.5$ V to $V_{CC}$ + $0.5$ V
ut clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0)	–20 mA
diode current, $I_{IOK}(V_{IO} < 0)$	–50 mA
itch through current, I <sub>T</sub> (V <sub>IO</sub> = 0 to V <sub>CC</sub> )	±25 mA
ntinuous current through V <sub>CC</sub> or GND	±50 mA
ckage thermal impedance, θ <sub>JA</sub> (see Note 3): D package	
DW package	57°C/W
PW package	108°C/W
rage temperature range, T <sub>stg</sub>	–65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.

- 2. This value is limited to 5.5 V maximum.
- 3. The package thermal impedance is calculated in accordance with JESD 51-7.

### recommended operating conditions (see Note 4)

			MIN	MAX	UNIT	
Vcc	Supply voltage		2‡	5.5	V	
		V <sub>CC</sub> = 2 V	1.5			
.,	High-level input voltage,	V <sub>CC</sub> = 2.3 V to 2.7 V	$V_{CC} \times 0.7$		V	
$V_{\text{IH}}$	control inputs	V <sub>CC</sub> = 3 V to 3.6 V	$V_{CC} \times 0.7$		V	
		V <sub>CC</sub> = 4.5 V to 5.5 V	$V_{CC} \times 0.7$			
		V <sub>CC</sub> = 2 V		0.5		
.,	Low-level input voltage,	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		$V_{CC} \times 0.3$	V	
$V_{IL}$	control inputs	V <sub>CC</sub> = 3 V to 3.6 V		$V_{CC} \times 0.3$	V	
		V <sub>CC</sub> = 4.5 V to 5.5 V		$V_{CC} \times 0.3$		
VI	Control input voltage		0	5.5	V	
V <sub>IO</sub>	Input/output voltage		0	VCC	V	
		V <sub>CC</sub> = 2.3 V to 2.7 V		200		
Δt/Δν	Input transition rise or fall rate	V <sub>CC</sub> = 3 V to 3.6 V		100	ns/V	
		V <sub>CC</sub> = 4.5 V to 5.5 V		20		
TA	Operating free-air temperature		-40	105	°C	

<sup>‡</sup> With supply voltages at or near 2 V, the analog switch on-state resistance becomes very nonlinear. It is recommended that only digital signals be transmitted at these low supply voltages.

NOTE 4: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.



## SN74LV4051A-EP 8-CHANNEL ANALOG MULTIPLEXER/DEMULTIPLEXER

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## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

			.,	T,	\ = 25°C	;			
	PARAMETER	TEST CONDITIONS	VCC	MIN	TYP	MAX	MIN	MAX	UNIT
			2.3 V		38	180		225	
ron	On-state switch resistance	$I_T = 2 \text{ mA}, V_I = V_{CC} \text{ or GND},$ $V_{INH} = V_{II}, \text{ (see Figure 1)}$	3 V		30	150		190	Ω
		THAM TIE, (999 Figure 1)	4.5 V		22	75		100	
		1 0 A V V V (- CND	2.3 V		113	500		600	
ron(p)	Peak on-state resistance	$I_T = 2 \text{ mA}, V_I = V_{CC} \text{ to GND},$ $V_{INH} = V_{II}$	3 V		54	180		225	Ω
,		VIIVIT — VIL	4.5 V		31	100		125	
	Difference in on-state		2.3 V		2.1	30		40	
$\Delta r_{on}$	resistance between	$I_T = 2 \text{ mA}, V_I = V_{CC} \text{ to GND},$ $V_{INH} = V_{II}$	3 V		1.4	20		30	Ω
	switches	·IIVII ·IL	4.5 V		1.3	15		20	
IĮ	Control input current	V <sub>I</sub> = 5.5 V or GND	0 to 5.5 V			±0.1		±1	μΑ
IS(off)	Off-state switch leakage current	$V_I = V_{CC}$ and $V_O = GND$ , or $V_I = GND$ and $V_O = V_{CC}$ , $V_{INH} = V_{IH}$ , (see Figure 2)	5.5 V			±0.1		±1	μΑ
I <sub>S(on)</sub>	On-state switch leakage current	V <sub>I</sub> = V <sub>CC</sub> or GND, V <sub>INH</sub> = V <sub>IL</sub> (see Figure 3)	5.5 V			±0.1		±1	μΑ
Icc	Supply current	$V_I = V_{CC}$ or GND	5.5 V					20	μΑ
C <sub>IC</sub>	Control input capacitance	f = 10 MHz	3.3 V		2				pF
C <sub>IS</sub>	Common terminal capacitance		3.3 V	_	23.4				pF
COS	Switch terminal capacitance		3.3 V		5.7				pF
C <sub>F</sub>	Feedthrough capacitance		3.3 V		0.5				pF

## switching characteristics over recommended operating free-air temperature range, $V_{CC}$ = 2.5 V $\pm$ 0.2 V (unless otherwise noted)

PARAMETER		FROM	то	TEST	T,	չ = 25°C	;		MAY	
PAR	AMETER	(INPUT)	(OUTPUT)	CONDITIONS	MIN	TYP	MAX	MIN	MAX	UNIT
tPLH tPHL	Propagation delay time	COM or Yn	Yn or COM	C <sub>L</sub> = 15 pF, (see Figure 4)		1.9	10		16	ns
<sup>t</sup> PZH <sup>t</sup> PZL	Enable delay time	INH	COM or Yn	C <sub>L</sub> = 15 pF, (see Figure 5)		6.6	18		23	ns
<sup>t</sup> PHZ <sup>t</sup> PLZ	Disable delay time	INH	COM or Yn	C <sub>L</sub> = 15 pF, (see Figure 5)		7.4	18		23	ns
tPLH tPHL	Propagation delay time	COM or Yn	Yn or COM	C <sub>L</sub> = 50 pF, (see Figure 5)		3.8	12		18	ns
<sup>t</sup> PZH <sup>t</sup> PZL	Enable delay time	INH	COM or Yn	C <sub>L</sub> = 50 pF, (see Figure 5)		7.8	28		35	ns
<sup>t</sup> PHZ <sup>t</sup> PLZ	Disable delay time	INH	COM or Yn	C <sub>L</sub> = 50 pF, (see Figure 5)		11.5	28		35	ns



# SN74LV4051A-EP 8-CHANNEL ANALOG MULTIPLEXER/DEMULTIPLEXER

SCLS501D - MAY 2003 - REVISED MAY 2004

# switching characteristics over recommended operating free-air temperature range, $V_{CC}$ = 3.3 V $\pm$ 0.3 V (unless otherwise noted)

PARAMETER		FROM	то	TEST	Τμ	λ = 25°C	;	84181	88 A V	
PAR	AMETER	(INPUT)	(OUTPUT)	CONDITIONS	MIN	TYP	MAX	MIN	MAX	UNIT
<sup>t</sup> PLH <sup>t</sup> PHL	Propagation delay time	COM or Yn	Yn or COM	C <sub>L</sub> = 15 pF, (see Figure 4)		1.2	6		10	ns
<sup>t</sup> PZH <sup>t</sup> PZL	Enable delay time	INH	COM or Yn	C <sub>L</sub> = 15 pF, (see Figure 5)		4.7	12		15	ns
tPHZ tPLZ	Disable delay time	INH	COM or Yn	C <sub>L</sub> = 15 pF, (see Figure 5)		5.7	12		15	ns
tPLH tPHL	Propagation delay time	COM or Yn	Yn or COM	C <sub>L</sub> = 50 pF, (see Figure 4)		2.5	9		12	ns
<sup>t</sup> PZH <sup>t</sup> PZL	Enable delay time	INH	COM or Yn	C <sub>L</sub> = 50 pF, (see Figure 5)		5.5	20		25	ns
tPHZ tPLZ	Disable delay time	INH	COM or Yn	C <sub>L</sub> = 50 pF, (see Figure 5)		8.8	20		25	ns

# switching characteristics over recommended operating free-air temperature range, $V_{CC}$ = 5 V $\pm$ 0.5 V (unless otherwise noted)

PARAMETER		FROM	то	TEST	T	λ = 25°C	;	MAINI	MAN	
PAR	AMETER	(INPUT)	(OUTPUT)	CONDITIONS	MIN	TYP	MAX	MIN	MAX	UNIT
<sup>t</sup> PLH <sup>t</sup> PHL	Propagation delay time	COM or Yn	Yn or COM	C <sub>L</sub> = 15 pF, (see Figure 4)		0.6	4		7	ns
<sup>t</sup> PZH <sup>t</sup> PZL	Enable delay time	INH	COM or Yn	C <sub>L</sub> = 15 pF, (see Figure 5)		3.5	8		10	ns
<sup>t</sup> PHZ <sup>t</sup> PLZ	Disable delay time	INH	COM or Yn	C <sub>L</sub> = 15 pF, (see Figure 5)		4.4	8		10	ns
tPLH tPHL	Propagation delay time	COM or Yn	Yn or COM	C <sub>L</sub> = 50 pF, (see Figure 4)		1.5	6		8	ns
<sup>t</sup> PZH <sup>t</sup> PZL	Enable delay time	INH	COM or Yn	C <sub>L</sub> = 50 pF, (see Figure 5)		4	14	·	18	ns
<sup>t</sup> PHZ <sup>t</sup> PLZ	Disable delay time	INH	COM or Yn	C <sub>L</sub> = 50 pF, (see Figure 5)		6.2	14		18	ns

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## analog switch characteristics over recommended operating free-air temperature range (unless otherwise noted)

24244555	FROM	то	7707.00	IDITIONS.	.,	T,	ղ = 25°C	;		
PARAMETER	(INPUT)	(OUTPUT)	TEST CO	NDITIONS	VCC	MIN	TYP	MAX	UNIT	
			C <sub>L</sub> = 50 pF,		2.3 V		20			
Frequency response (switch on)	COM or Yn	Yn or COM	$R_L = 600 \Omega$ , $f_{in} = 1 MHz$ (sir	ne wave)	3 V		25		MHz	
(cimen city			(see Note 5 and		4.5 V		35			
Crosstalk			C <sub>L</sub> = 50 pF,		2.3 V		20			
(control input to signal	INH	COM or Yn	$R_L = 600 \Omega$ , $f_{in} = 1 \text{ MHz (square wave)}$ (see Figure 7)		3 V		35		mV	
output)					4.5 V		60			
			$C_L = 50 \text{ pF},$ $R_L = 600 \Omega,$ $f_{in} = 1 \text{ MHz}$ (see Note 6 and Figure 8)		2.3 V		-45		dB	
Feedthrough attenuation (switch off)	COM or Yn	Yn or COM			3 V		-45			
(Girilan Gir)					4.5 V		-45			
			C <sub>L</sub> = 50 pF,	V <sub>I</sub> = 2 V <sub>p-p</sub>	2.3 V		0.1			
Sine-wave distortion	COM or Yn	Yn or COM	$R_L = 10 \text{ k}\Omega,$ $f_{\text{in}} = 1 \text{ kHz}$	V <sub>I</sub> = 2.5 V <sub>p-p</sub>	3 V		0.1		%	
			(sine wave) (see Figure 9)	V <sub>I</sub> = 4 V <sub>p-p</sub>	4.5 V		0.1			

NOTES: 5. Adjust  $f_{in}$  voltage to obtain 0-dBm output. Increase  $f_{in}$  frequency until dB meter reads -3 dB.

## operating characteristics, $V_{CC} = 3.3 \text{ V}$ , $T_A = 25^{\circ}\text{C}$

	PARAMETER	TEST CON	TYP	UNIT	
C <sub>pd</sub>	Power dissipation capacitance	C <sub>L</sub> = 50 pF,	f = 10 MHz	5.9	pF

#### PARAMETER MEASUREMENT INFORMATION

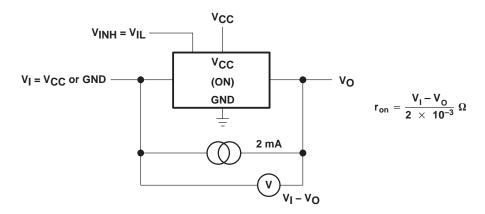
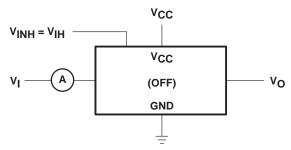


Figure 1. On-State Resistance Test Circuit

<sup>6.</sup> Adjust fin voltage to obtain 0-dBm input.

#### PARAMETER MEASUREMENT INFORMATION



Condition 1:  $V_I = 0$ ,  $V_O = V_{CC}$ Condition 2:  $V_I = V_{CC}$ ,  $V_O = 0$ 

Figure 2. Off-State Switch Leakage-Current Test Circuit

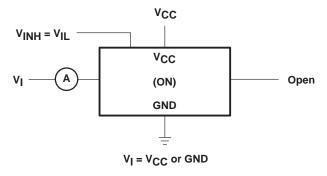


Figure 3. On-State Switch Leakage-Current Test Circuit

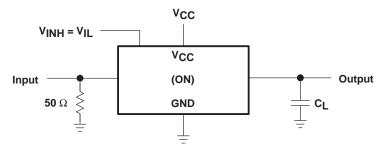


Figure 4. Propagation Delay Time, Signal Input to Signal Output

#### PARAMETER MEASUREMENT INFORMATION

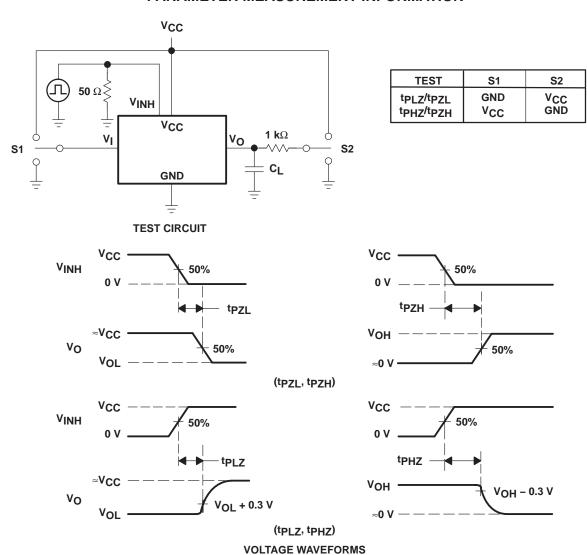


Figure 5. Switching Time (t<sub>PZL</sub>, t<sub>PLZ</sub>, t<sub>PZH</sub>, t<sub>PHZ</sub>), Control to Signal Output

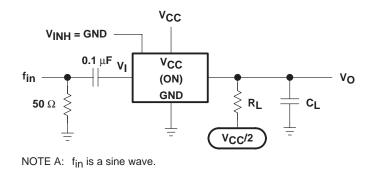


Figure 6. Frequency Response (Switch On)



#### PARAMETER MEASUREMENT INFORMATION

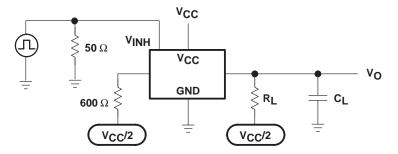


Figure 7. Crosstalk (Control Input, Switch Output)

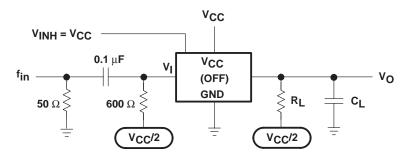


Figure 8. Feedthrough Attenuation (Switch Off)

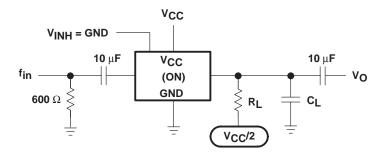


Figure 9. Sine-Wave Distortion



#### PACKAGE OPTION ADDENDUM

TEXAS INSTRUMENTS

10-Dec-2020

#### **PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
SN74LV4051ATDREP	ACTIVE	SOIC	D	16	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 105	LV4051ATEP	Samples
SN74LV4051ATPWREP	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 105	L4051EP	Samples
V62/03664-01XE	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 105	L4051EP	Samples
V62/03664-01YE	ACTIVE	SOIC	D	16	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 105	LV4051ATEP	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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### **PACKAGE OPTION ADDENDUM**

10-Dec-2020

continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

#### OTHER QUALIFIED VERSIONS OF SN74LV4051A-EP:

◆ Catalog: SN74LV4051A

Automotive: SN74LV4051A-Q1

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Automotive Q100 devices qualified for high-reliability automotive applications targeting zero defects

## PACKAGE MATERIALS INFORMATION

www.ti.com 3-Aug-2021

#### TAPE AND REEL INFORMATION





		Dimension designed to accommodate the component width
E	30	Dimension designed to accommodate the component length
K	(0	Dimension designed to accommodate the component thickness
	Ν	Overall width of the carrier tape
F	21	Pitch between successive cavity centers

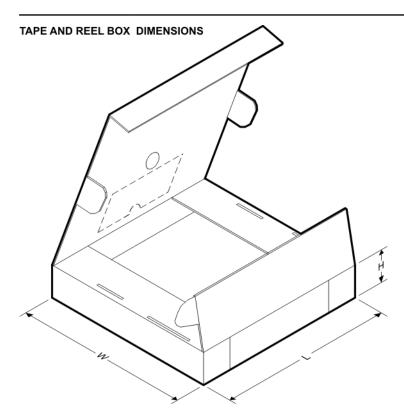
#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LV4051ATDREP	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
SN74LV4051ATPWREP	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

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#### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74LV4051ATDREP	SOIC	D	16	2500	340.5	336.1	32.0
SN74LV4051ATPWREP	TSSOP	PW	16	2000	853.0	449.0	35.0

## D (R-PDS0-G16)

#### PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



## D (R-PDSO-G16)

## PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.





SMALL OUTLINE PACKAGE



#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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